PD-90554F

International

POWER MOSFET THRU-HOLE (TO-254AA)

Product Summary

Part Number	RDS(on)	ID
IRFM250	0.100 Ω	27.4A

HEXFET[®] MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.

IRFM250 JANTX2N7225 JANTXV2N7225 REF:MIL-PRF-19500/592 200V, N-CHANNEL HEXFET[®] MOSFET TECHNOLOGY



Features:

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Dynamic dv/dt Rating
- Light-weight

	Parameter		Units	
ID @ VGS = 10V, TC = 25°C Continuous Drain Current		27.4		
ID @ VGS = 10V, TC = 100°C Continuous Drain Current		17	A	
IDM	Pulsed Drain Current ①	110	1	
P _D @ T _C = 25°C	Max. Power Dissipation	150	W	
	Linear Derating Factor	1.2	W/°C	
VGS	Gate-to-Source Voltage	±20	V	
EAS	Single Pulse Avalanche Energy 2	500	mJ	
lar	Avalanche Current 1	27.4	Α	
EAR	Repetitive Avalanche Energy ①	15	mJ	
dv/dt	Peak Diode Recovery dv/dt 3	5.0	V/ns	
Тј	Operating Junction	-55 to 150		
TSTG Storage Temperature Range			°C	
	Lead Temperature	300 (0.063 in.(1.6mm) from case for 10s)		
	Weight	9.3 (Typical)	g	

Absolute Maximum Ratings

For footnotes refer to the last page

International **ISR** Rectifier

Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

	Parameter	Min	Тур	Max	Units	Test Conditions
BVDSS	Drain-to-Source Breakdown Voltage	200	_	_	V	VGS = 0V, ID = 1.0mA
∆BV _{DSS} /∆TJ	Temperature Coefficient of Breakdown Voltage		0.28	_	V/°C	Reference to 25°C, I _D = 1.0mA
RDS(on)	Static Drain-to-Source On-State	—	—	0.100	Ω	VGS = 10V, ID = 17A
	Resistance	—	—	0.105	- 22	VGS = 10V, ID = 27.4A
VGS(th)	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
9fs	Forward Transconductance	9.0	—	—	S	V _{DS} = 15V, I _{DS} = 17A ④
IDSS	Zero Gate Voltage Drain Current	—	—	25	μA	VDS= 160V ,VGS = 0V
		—	—	250	μΑ	V _{DS} = 160V,
						V _{GS} = 0V, T _J = 125°C
IGSS	Gate-to-Source Leakage Forward	—	—	100		$V_{GS} = 20V$
IGSS	Gate-to-Source Leakage Reverse	—	—	-100	nA	V _{GS} = -20V
Qg	Total Gate Charge		—	115		VGS =10V, ID = 27.4A
Qgs	Gate-to-Source Charge		—	22	nC	VDS = 100V
Q _{gd}	Gate-to-Drain ('Miller') Charge	—	—	60		
td(on)	Turn-On Delay Time	—	—	35		$V_{DD} = 100V, I_D = 27.4A,$
tr	Rise Time	—	—	190		$V_{GS} = 10V, R_{G} = 2.35\Omega$
^t d(off)	Turn-Off Delay Time		—	170	ns	
tf	Fall Time		—	130		
LS + LD	Total Inductance	_	6.8	_	nH	Measured from drain lead (6mm/0.25in. from package) to source lead (6mm/0.25in. from package)
C _{iss}	Input Capacitance	_	3500	_		$V_{GS} = 0V, V_{DS} = 25V$
C _{oss}	Output Capacitance	_	700	_	pF	f = 1.0MHz
Crss	Reverse Transfer Capacitance	_	110	_		
CDC	Drain-to-Case Capacitance	—	12	—	İ	

Source-Drain Diode Ratings and Characteristics

	Parameter		Min	Тур	Max	Units	Test Conditions
IS	Continuous Source Current (Body Diode)	—	—	27.4	۸	
ISM	Pulse Source Current (Body	Diode) 1	_	_	110	Α	
VSD	Diode Forward Voltage		—	—	1.9	V	$T_j = 25^{\circ}C$, $I_S = 27.4A$, $V_{GS} = 0V$ (4)
trr	Reverse Recovery Time		_	—	950	ns	Tj = 25°C, IF = 27.4A, di/dt ≤ 100A/μs
QRR	Reverse Recovery Charge		—	—	9.0	μC	$V_{DD} \leq 50V @$
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_{S} + L_{D}$.					

Thermal Resistance

	Parameter	Min	Тур	Max	Units	Test Conditions
RthJC	Junction-to-Case	—	—	0.83		
RthJCS	Case-to-Sink	—	0.21	—	°C/W	
R _{th} JA	Junction-to-Ambient	—		48	ſ	Typical socket mount

Note: Corresponding Spice and Saber models are available on International Rectifier website.

For footnotes refer to the last page

International

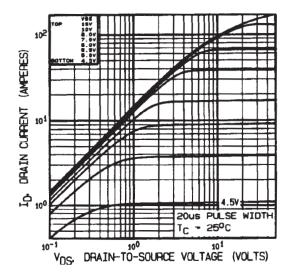


Fig 1. Typical Output Characteristics

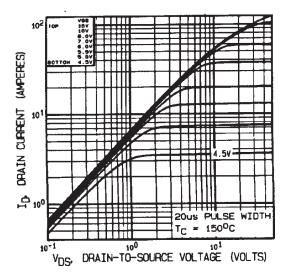


Fig 2. Typical Output Characteristics

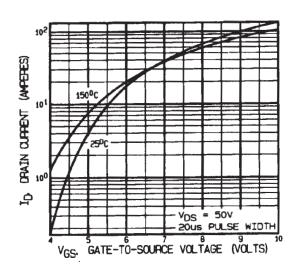


Fig 3. Typical Transfer Characteristics

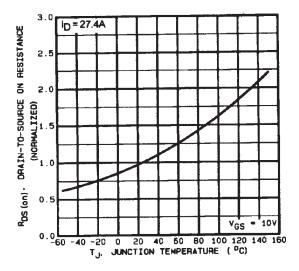


Fig 4. Normalized On-Resistance Vs. Temperature

International

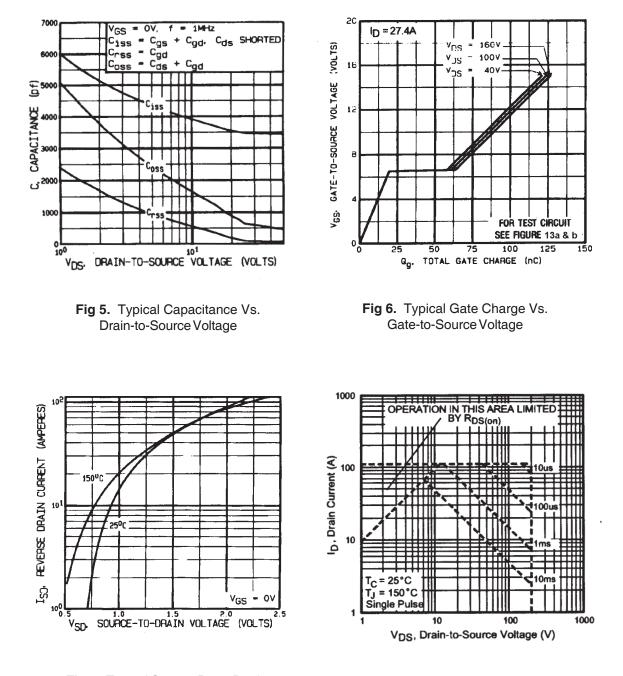
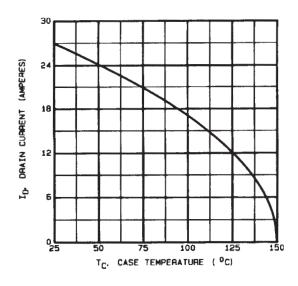


Fig 7. Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area

International





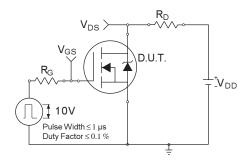


Fig 10a. Switching Time Test Circuit

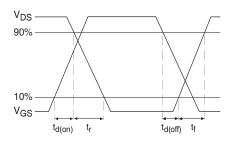


Fig 10b. Switching Time Waveforms

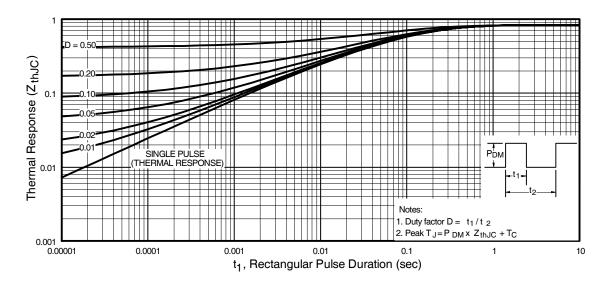


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

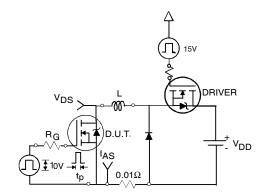


Fig 12a. Unclamped Inductive Test Circuit

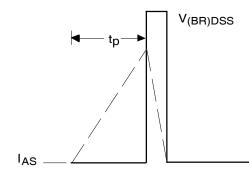


Fig 12b. Unclamped Inductive Waveforms

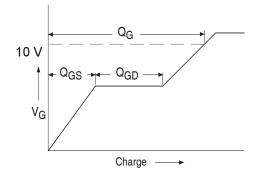


Fig 13a. Basic Gate Charge Waveform

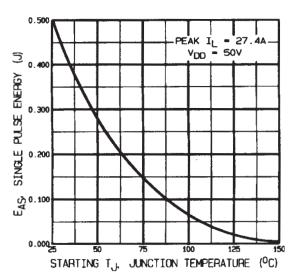


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

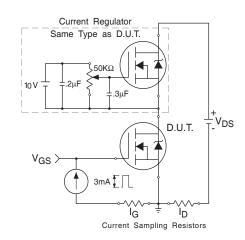


Fig 13b. Gate Charge Test Circuit

www.irf.com

6

International

Footnotes:

① Repetitive Rating; Pulse width limited by maximum junction temperature.

Case Outline and Dimensions — TO-254AA

- 2 V_DD = 50V, starting T_J = 25°C, L= 1.3mH Peak IL = 27.4A, VGS = 10V
- 3 ISD \leq 27.4A, di/dt \leq 190A/µs, VDD \leq 200V, TJ \leq 150°C
- ④ Pulse width \leq 300 µs; Duty Cycle \leq 2%
- 13.84 [.545] 6.60 [.260] Ø 3.78 [.149] 13.59 [.535] 6.32 [.249] 3.53 [.139] 1.27 [.050] 1.02 [.040] А 20.32 [.800] 17.40 [.685] B 20.07 [.790] 13.84 [.545] 16.89 [.665] 13.59 [.535] 2 3 C 14.48 (.570) 0.84 (.033) 12.95 (.510) MAX. 3X Ø 1.14 [.045] 0.89 [.035] - 3.81 [.150] 3.81 [.150] ⊕ Ø 0.36 [.014] Ŵ B AÛ 2X

NOTES:

- 1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3. CONTROLLING DIMENSION: INCH.
- 4. CONFORMS TO JEDEC OUTLINE TO-254AA.

CAUTION

BERYLLIA WARNING PER MIL-PRF-19500

Package containing beryllia shall not be ground, sandblasted, machined, or have other operations performed on them which will produce beryllia or beryllium dust. Furthermore, beryllium oxide packages shall not be placed in acids that will produce fumes containing beryllium.

International

PIN ASSIGNMENTS

1 = DRAIN 2 = SOURCE

3 = GATE

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105 IR LEOMINSTER : 205 Crawford St., Leominster, Massachusetts 01453, USA Tel: (978) 534-5776 TAC Fax: (310) 252-7903 Visit us at www.irf.com for sales contact information.

Data and specifications subject to change without notice. 10/2011

www.irf.com

7



单击下面可查看定价,库存,交付和生命周期等信息

>>Infineon Technologies(英飞凌)